

Application/Control No.	Applicant(s)/Patent under Reexamination
10/603,009	BAZIN ET AL.
Examiner	Art Unit
Nhon T. Diep	2621

SEARCHED					
Class	Subclass	Date	Examiner		

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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Interse	vence	Search	History	
Print-	ont	7/207	N.D.	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
Inventors scarch tast scarch	7/22/07	N.D.			
tast Scarch	7/22/07	W.D.			